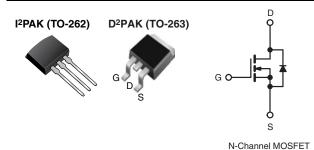


Vishay Siliconix

Power MOSFET

PRODUCT SUMMARY				
V _{DS} (V)	600			
$R_{DS(on)}(\Omega)$	V _{GS} = 10 V	2.2		
Q _g (Max.) (nC)	23			
Q _{gs} (nC)	5.4			
Q _{gd} (nC)	11			
Configuration	Single			



FEATURES • Halogen-free

- Halogen-free According to IEC 61249-2-21 Definition
- \bullet Low Gate Charge Q_{g} Results in Simple Drive Requirement



- Improved Gate, Avalanche and Dynamic dV/dt Ruggedness
- Fully Characterized Capacitance and Avalanche Voltage and Current
- Effective Coss Specified
- Compliant to RoHS Directive 2002/95/EC

APPLICATIONS

- Switch Mode Power Supply (SMPS)
- Uninterruptible Power Supply
- High Speed Power Switching

TYPICAL SMPS TOPOLOGIES

• Single Transistor Flyback

ORDERING INFORMATION					
Package	D ² PAK (TO-263)	D ² PAK (TO-263)	D ² PAK (TO-263)	I ² PAK (TO-262)	
Lead (Pb)-free and Halogen-free	SiHFBC30AS-GE3	SiHFBC30ASTRL-GE3 ^a	SiHFBC30ASTRR-GE3a	SiHFBC30AL-GE3	
Lead (Pb)-free	IRFBC30ASPbF	IRFBC30ASTRLPbFa	IRFBC30ASTRRPbFa	IRFBC30ALPbF	
	SiHFBC30AS-E3	SiHFBC30ASTL-E3a	SiHFBC30ASTR-E3a	SiHFBC30AL-E3	

Note

a. See device orientation.

ABSOLUTE MAXIMUM RATINGS (T _C = 25 °C, unless otherwise noted)						
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V _{DS}	600	V	
Gate-Source Voltage			V _{GS}	± 30		
Continuous Drain Current	V_{GS} at 10 V $T_C = 25 ^{\circ}C$ $T_C = 100 ^{\circ}C$		3.6			
		T _C = 100 °C	I _D	2.3	А	
Pulsed Drain Current ^{a, e}			I _{DM}	14		
Linear Derating Factor				0.69	W/°C	
Single Pulse Avalanche Energy ^b			E _{AS}	290	mJ	
Avalanche Current ^a			I _{AR}	3.6	А	
Repetiitive Avalanche Energy ^a			E _{AR}	7.4	mJ	
Maximum Power Dissipation	T _C = 25 °C		P_{D}	74	W	
Peak Diode Recovery dV/dtc, e			dV/dt	7.0	V/ns	
Operating Junction and Storage Temperature Range			T _J , T _{stg}	- 55 to + 150	• °C	
Soldering Recommendations (Peak Temperature)	for	10 s		300 ^d		

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Starting T_J = 25 °C, L = 46 mH, R_g = 25 Ω , I_{AS} = 3.6 A (see fig. 12).
- c. $I_{SD} \le 3.6 \text{ A}$, $dI/dt \le 170 \text{ A/}\mu\text{s}$, $V_{DD} \le V_{DS}$, $T_{J} \le 150 \,^{\circ}\text{C}$.
- d. 1.6 mm from case.
- e. Uses IRFBC30A/SiHFBC30A data and test conditions.

^{*} Pb containing terminations are not RoHS compliant, exemptions may apply

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THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	TYP.	MAX.	UNIT	
Maximum Junction-to-Ambient (PCB Mounted, steady-state) ^a	R _{thJA}	-	40	°C/W	
Maximum Junction-to-Case (Drain)	R _{thJC}	-	1.7		

Note

a. When mounted on 1" square PCB (FR-4 or G-10 material).

PARAMETER	SYMBOL	TES	TEST CONDITIONS		TYP.	MAX.	UNIT
Static							
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0$, $I_D = 250 \mu A$		600	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Referenc	Reference to 25 °C, I _D = 1 mA ^d		0.67	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_D = 250 \mu A$		2.0	-	4.5	V
Gate-Source Leakage	I _{GSS}	V _{GS} = ± 30 V		-	-	± 100	nA
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 600 V, V _{GS} = 0 V		-	-	25	μΑ
		V _{DS} = 480 \	V _{DS} = 480 V, V _{GS} = 0 V, T _J = 125 °C		-	250	
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V	$I_D = 2.2 A^b$	-	-	2.2	Ω
Forward Transconductance	g _{fs}	V _{DS} = 50 V, I _D = 2.2 A		2.1	-	-	S
Dynamic							
Input Capacitance	C_{iss}		$V_{GS} = 0 V$,		510	-	
Output Capacitance	C _{oss}	$V_{DS} = 25 \text{ V},$ $V_{DS} = 25 \text{ V},$ f = 1.0 MHz, see fig. 5		-	70	-	
Reverse Transfer Capacitance	C _{rss}			-	3.5	-	
Output Capacitance	C _{oss}	V _{GS} = 0 V	$V_{DS} = 1.0 \text{ V}, f = 1.0 \text{ MHz}$	1	730	-	pF -
			$V_{DS} = 480 \text{ V}, f = 1.0 \text{ MHz}$	1	19	-	
Effective Output Capacitance	Coss eff.		V _{DS} = 0 V to 480 V ^c		31	-	
Total Gate Charge	Q_g			1	-	23	
Gate-Source Charge	Q_{gs}	$V_{GS} = 10 \text{ V}$ $I_D = 3.6 \text{ A}, V_{DS} = 480 \text{ V},$ see fig. 6 and 13 ^b		1	-	5.4	nC
Gate-Drain Charge	Q_{gd}		3	1	-	11	
Turn-On Delay Time	t _{d(on)}	V_{DD} = 300 V, I_D = 3.6 A, R_g = 12 Ω, R_D = 82 Ω, see fig. 10 ^{b, d}		ı	9.8	-	- ns
Rise Time	t _r			1	13	-	
Turn-Off Delay Time	$t_{d(off)}$			-	19	-	
Fall Time	t _f			1	12	-	
Drain-Source Body Diode Characteristic	s						
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		i	-	3.6	A
Pulsed Diode Forward Current ^a	I _{SM}			-	-	14	
Body Diode Voltage	V_{SD}	$T_J = 25$ °C, $I_S = 3.6$ A, $V_{GS} = 0$ V ^b		-	-	1.6	V
Body Diode Reverse Recovery Time	t _{rr}	T _J = 25 °C, I _F = 3.6 A, dl/dt = 100 A/µs ^b .		-	400	600	ns
Body Diode Reverse Recovery Charge	Q_{rr}			-	1.1	1.7	μC
Forward Turn-On Time	t _{on}	Intrinsic tu	on is dor	ninated b	v L o and	12)	

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width \leq 300 µs; duty cycle \leq 2 %.
- c. C_{oss} eff. is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 to 80 % V_{DS} .
- d. Uses IRFBC30A/SiHFBC30A data and test conditions.

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TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

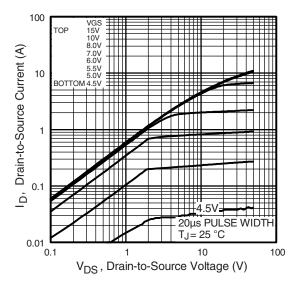


Fig. 1 - Typical Output Characteristics

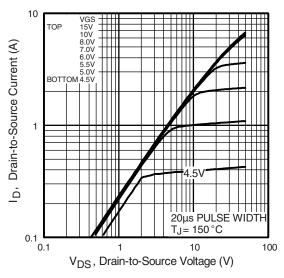


Fig. 2 - Typical Output Characteristics

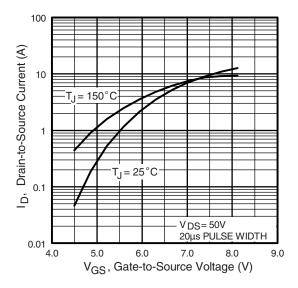


Fig. 3 - Typical Transfer Characteristics

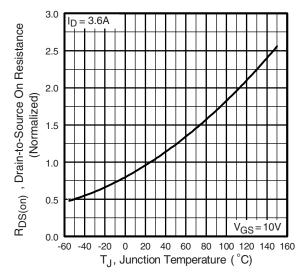


Fig. 4 - Normalized On-Resistance vs. Temperature

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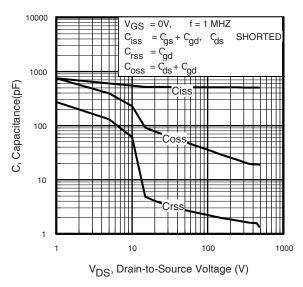


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

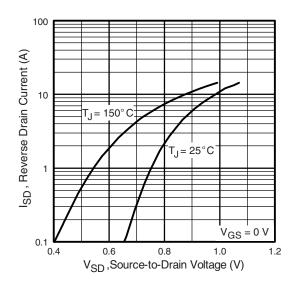


Fig. 7 - Typical Source-Drain Diode Forward Voltage

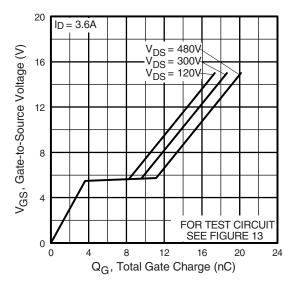


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

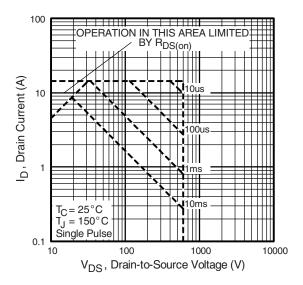


Fig. 8 - Maximum Safe Operating Area

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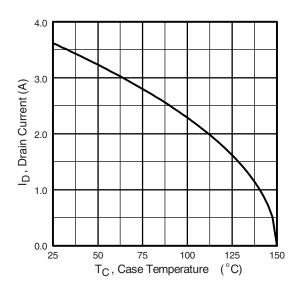


Fig. 9 - Maximum Drain Current vs. Case Temperature

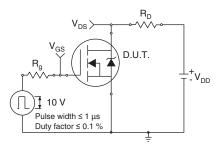


Fig. 10a - Switching Time Test Circuit

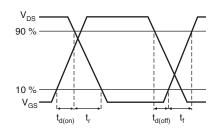


Fig. 10b - Switching Time Waveforms

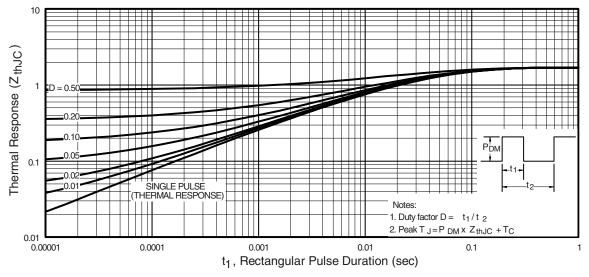


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

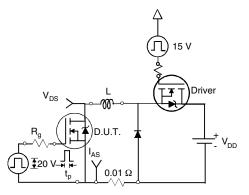


Fig. 12a - Unclamped Inductive Test Circuit

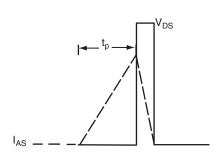


Fig. 12b - Unclamped Inductive Waveforms

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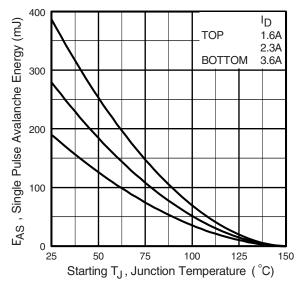


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

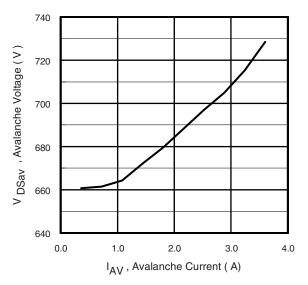


Fig. 12d - Typical Drain-to-Source Voltage vs. Avalanache Current

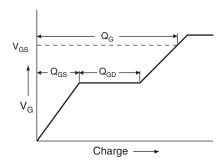


Fig. 13a - Basic Gate Charge Waveform

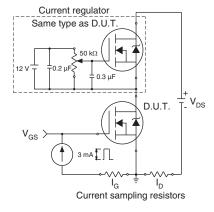
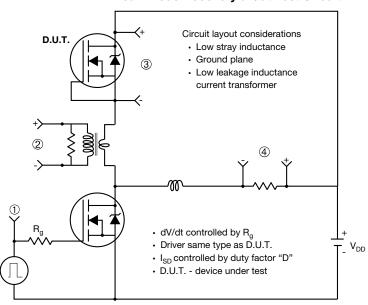


Fig. 13b - Gate Charge Test Circuit

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Peak Diode Recovery dV/dt Test Circuit



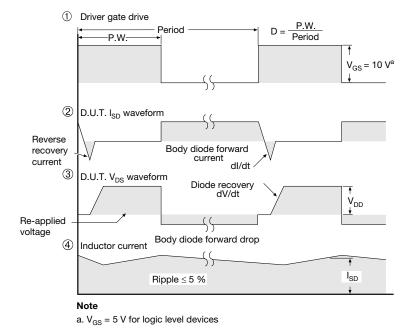


Fig. 14 - For N-Channel

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